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[Understanding Embedded - FPGAs \(Field Programmable Gate Array\)](#)

Embedded - FPGAs, or Field Programmable Gate Arrays, are advanced integrated circuits that offer unparalleled flexibility and performance for digital systems. Unlike traditional fixed-function logic devices, FPGAs can be programmed and reprogrammed to execute a wide array of logical operations, enabling customized functionality tailored to specific applications. This reprogrammability allows developers to iterate designs quickly and implement complex functions without the need for custom hardware.

Applications of Embedded - FPGAs

The versatility of Embedded - FPGAs makes them indispensable in numerous fields. In telecommunications.

Details

Product Status	Obsolete
Number of LABs/CLBs	-
Number of Logic Elements/Cells	-
Total RAM Bits	-
Number of I/O	57
Number of Gates	3000
Voltage - Supply	3V ~ 3.6V, 4.75V ~ 5.25V
Mounting Type	Surface Mount
Operating Temperature	0°C ~ 70°C (TA)
Package / Case	100-BQFP
Supplier Device Package	100-PQFP (20x14)
Purchase URL	https://www.e-xfl.com/product-detail/microchip-technology/a40mx02-1pq100



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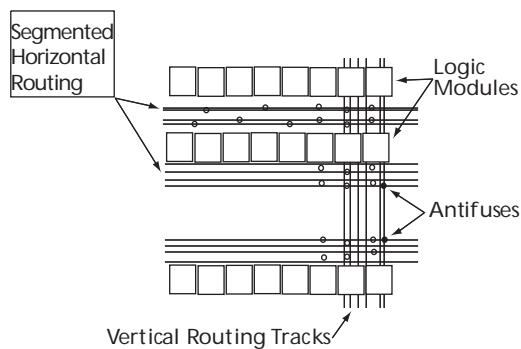
About Microsemi

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3.2.3.3 Antifuse Structures

An antifuse is a “normally open” structure. The use of antifuses to implement a programmable logic device results in highly testable structures as well as efficient programming algorithms. There are no pre-existing connections; temporary connections can be made using pass transistors. These temporary connections can isolate individual antifuses to be programmed and individual circuit structures to be tested, which can be done before and after programming. For instance, all metal tracks can be tested for continuity and shorts between adjacent tracks, and the functionality of all logic modules can be verified.

Figure 7 • MX Routing Structure



3.2.4 Clock Networks

The 40MX devices have one global clock distribution network (CLK). A signal can be put on the CLK network by being routed through the CLKBUF buffer.

In 42MX devices, there are two low-skew, high-fanout clock distribution networks, referred to as CLKA and CLKB. Each network has a clock module (CLKMOD) that can select the source of the clock signal from any of the following (Figure 8, page 11):

- Externally from the CLKA pad, using CLKBUF buffer
- Externally from the CLKB pad, using CLKBUF buffer
- Internally from the CLKINTA input, using CLKINT buffer
- Internally from the CLKINTB input, using CLKINT buffer

The clock modules are located in the top row of I/O modules. Clock drivers and a dedicated horizontal clock track are located in each horizontal routing channel.

Clock input pads in both 40MX and 42MX devices can also be used as normal I/Os, bypassing the clock networks.

The A42MX36 device has four additional register control resources, called quadrant clock networks (Figure 9, page 11). Each quadrant clock provides a local, high-fanout resource to the contiguous logic modules within its quadrant of the device. Quadrant clock signals can originate from specific I/O pins or from the internal array and can be used as a secondary register clock, register clear, or output enable.

Each I/O cell has three boundary-scan register cells, each with a serial-in, serial-out, parallel-in, and parallel-out pin. The serial pins are used to serially connect all the boundary-scan register cells in a device into a boundary-scan register chain, which starts at the TDI pin and ends at the TDO pin. The parallel ports are connected to the internal core logic tile and the input, output and control ports of an I/O buffer to capture and load data into the register to control or observe the logic state of each I/O.

Figure 14 • 42MX IEEE 1149.1 Boundary Scan Circuitry

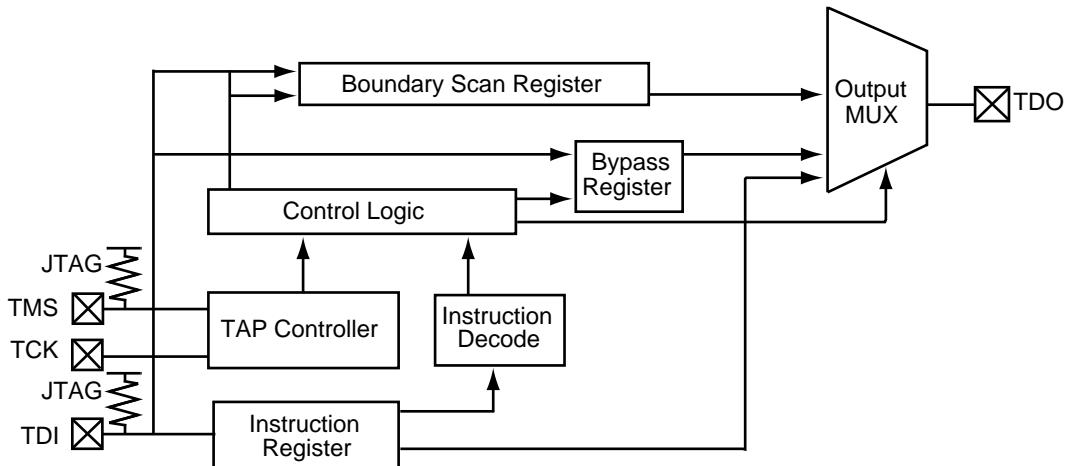


Table 9 • Test Access Port Descriptions

Port	Description
TMS (Test Mode Select)	Serial input for the test logic control bits. Data is captured on the rising edge of the test logic clock (TCK).
TCK (Test Clock Input)	Dedicated test logic clock used serially to shift test instruction, test data, and control inputs on the rising edge of the clock, and serially to shift the output data on the falling edge of the clock. The maximum clock frequency for TCK is 20 MHz.
TDI (Test Data Input)	Serial input for instruction and test data. Data is captured on the rising edge of the test logic clock.
TDO (Test Data Output)	Serial output for test instruction and data from the test logic. TDO is set to an Inactive Drive state (high impedance) when data scanning is not in progress.

Table 10 • Supported BST Public Instructions

Instruction	IR Code (IR2.IR0)	Instruction Type	Description
EXTEST	000	Mandatory	Allows the external circuitry and board-level interconnections to be tested by forcing a test pattern at the output pins and capturing test results at the input pins.
SAMPLE/PRELOAD	001	Mandatory	Allows a snapshot of the signals at the device pins to be captured and examined during operation
HIGH Z	101	Optional	Tristates all I/Os to allow external signals to drive pins. See the IEEE Standard 1149.1 specification.
CLAMP	110	Optional	Allows state of signals driven from component pins to be determined from the Boundary-Scan Register. See the IEEE Standard 1149.1 specification for details.
BYPASS	111	Mandatory	Enables the bypass register between the TDI and TDO pins. The test data passes through the selected device to adjacent devices in the test chain.

Table 23 • DC Specification (5.0 V PCI Signaling)¹

Symbol	Parameter	Condition	PCI		MX		Units
			Min.	Max.	Min.	Max.	
C _{IN}	Input Pin Capacitance			10	—	10	pF
C _{CLK}	CLK Pin Capacitance		5	12	—	10	pF
L _{PIN}	Pin Inductance			20	—	< 8 nH ⁴	nH

1. PCI Local Bus Specification, Version 2.1, Section 4.2.1.1.

2. Maximum rating for VCCI –0.5 V to 7.0 V

3. VIH(Min) is 2.4V for A42MX36 family. This applies only to VCCI of 5V and is not applicable to VCCI of 3.3V.

4. Dependent upon the chosen package. PCI recommends QFP and BGA packaging to reduce pin inductance and capacitance.

Table 24 • AC Specifications (5.0V PCI Signaling)*

Symbol	Parameter	Condition	PCI		MX		Units
			Min.	Max.	Min.	Max.	
ICL	Low Clamp Current	–5 < VIN ≤ –1	–25 + (VIN +1) /0.015		–60	–10	mA
Slew (r)	Output Rise Slew Rate	0.4 V to 2.4 V load	1		5	1.8	2.8
Slew (f)	Output Fall Slew Rate	2.4 V to 0.4 V load	1		5	2.8	4.3
					V/ns	V/ns	

Note: *PCI Local Bus Specification, Version 2.1, Section 4.2.1.2.

3.9.3 Output Drive Characteristics for 3.3 V PCI Signaling

Table 25 • DC Specification (3.3 V PCI Signaling)¹

Symbol	Parameter	Condition	PCI		MX		Units
			Min.	Max.	Min.	Max.	
VCCI	Supply Voltage for I/Os		3.0	3.6	3.0	3.6 ²	V
VIH	Input High Voltage		0.5	VCC + 0.5	0.5	VCCI + 0.3	V
VIL	Input Low Voltage		-0.5	0.8	-0.3	0.8	V
I _{IH}	Input High Leakage Current	VIN = 2.7 V		70		10	µA
I _{IL}	Input Leakage Current			-70		-10	µA
VOH	Output High Voltage	I _{OUT} = -2 mA	0.9		3.3		V
VOL	Output Low Voltage	I _{OUT} = 3 mA, 6 mA		0.1		0.1 VCCI	V
C _{IN}	Input Pin Capacitance			10		10	pF
C _{CLK}	CLK Pin Capacitance		5	12		10	pF
L _{PIN}	Pin Inductance			20		< 8 nH ³	nH

1. PCI Local Bus Specification, Version 2.1, Section 4.2.2.1.

2. Maximum rating for VCCI -0.5 V to 7.0V.

3. Dependent upon the chosen package. PCI recommends QFP and BGA packaging to reduce pin inductance and capacitance.

Table 26 • AC Specifications for (3.3 V PCI Signaling)*

Symbol	Parameter	Condition	PCI		MX		Units
			Min.	Max.	Min.	Max.	
ICL	Low Clamp Current	-5 < VIN ≤ -1	-25 + (VIN +1) /0.015		-60	-10	mA
Slew (r)	Output Rise Slew Rate	0.2 V to 0.6 V load	1		4	1.8	V/ns
Slew (f)	Output Fall Slew Rate	0.6 V to 0.2 V load	1		4	2.8	4.0
							V/ns

Note: *PCI Local Bus Specification, Version 2.1, Section 4.2.2.2.

Table 35 • A40MX02 Timing Characteristics (Nominal 3.3 V Operation) (continued)
 (Worst-Case Commercial Conditions, VCC = 3.0 V, T_J = 70°C)

Parameter / Description	-3 Speed		-2 Speed		-1 Speed		Std Speed		-F Speed		Units
	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	
CMOS Output Module Timing⁴											
t _{DH}	Data-to-Pad HIGH	5.5	6.4	7.2	8.5	11.9	ns				
t _{DHL}	Data-to-Pad LOW	4.8	5.5	6.2	7.3	10.2	ns				
t _{ENZH}	Enable Pad Z to HIGH	4.7	5.5	6.2	7.3	10.2	ns				
t _{ENZL}	Enable Pad Z to LOW	6.8	7.9	8.9	10.5	14.7	ns				
t _{ENHZ}	Enable Pad HIGH to Z	11.1	12.8	14.5	17.1	23.9	ns				
t _{ENLZ}	Enable Pad LOW to Z	8.2	9.5	10.7	12.6	17.7	ns				
d _{TLH}	Delta LOW to HIGH	0.05	0.05	0.06	0.07	0.10	ns/pF				
d _{THL}	Delta HIGH to LOW	0.03	0.03	0.04	0.04	0.06	ns/pF				

1. Routing delays are for typical designs across worst-case operating conditions. These parameters should be used for estimating device performance. Post-route timing analysis or simulation is required to determine actual performance.
2. Set-up times assume fanout of 3. Further testing information can be obtained from the Timer utility.
3. The hold time for the DFME1A macro may be greater than 0 ns. Use the Timer tool from the Designer software to check the hold time for this macro
4. Delays based on 35 pF loading

Table 36 • A40MX04 Timing Characteristics (Nominal 5.0 V Operation) (Worst-Case Commercial Conditions, VCC = 4.75 V, T_J = 70°C)

Parameter / Description	-3 Speed		-2 Speed		-1 Speed		Std Speed		-F Speed		Units
	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	
Logic Module Propagation Delays											
t _{PD1}	Single Module	1.2	1.4	1.6	1.9	2.7	ns				
t _{PD2}	Dual-Module Macros	2.3	3.1	3.5	4.1	5.7	ns				
t _{CO}	Sequential Clock-to-Q	1.2	1.4	1.6	1.9	2.7	ns				
t _{GO}	Latch G-to-Q	1.2	1.4	1.6	1.9	2.7	ns				
t _{RS}	Flip-Flop (Latch) Reset-to-Q	1.2	1.4	1.6	1.9	2.7	ns				
Logic Module Predicted Routing Delays¹											
t _{RD1}	FO = 1 Routing Delay	1.2	1.6	1.8	2.1	3.0	ns				
t _{RD2}	FO = 2 Routing Delay	1.9	2.2	2.5	2.9	4.1	ns				
t _{RD3}	FO = 3 Routing Delay	2.4	2.8	3.2	3.7	5.2	ns				
t _{RD4}	FO = 4 Routing Delay	2.9	3.4	3.9	4.5	6.3	ns				
t _{RD8}	FO = 8 Routing Delay	5.0	5.8	6.6	7.8	10.9	ns				
Logic Module Sequential Timing²											
t _{SUD}	Flip-Flop (Latch) Data Input Set-Up	3.1	3.5	4.0	4.7	6.6	ns				
t _{HD} ³	Flip-Flop (Latch) Data Input Hold	0.0	0.0	0.0	0.0	0.0	ns				
t _{SUENA}	Flip-Flop (Latch) Enable Set-Up	3.1	3.5	4.0	4.7	6.6	ns				

Table 38 • A42MX09 Timing Characteristics (Nominal 5.0 V Operation) (continued)(Worst-Case Commercial Conditions, VCCA = 4.75 V, TJ = 70°C)

Parameter / Description		-3 Speed		-2 Speed		-1 Speed		Std Speed		-F Speed		Units
		Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	
Input Module Propagation Delays												
t _{INYH}	Pad-to-Y HIGH			1.0	1.2	1.3	1.6	2.2	ns			
t _{INYL}	Pad-to-Y LOW			0.8	0.9	1.0	1.2	1.7	ns			
t _{INGH}	G to Y HIGH			1.3	1.4	1.6	1.9	2.7	ns			
t _{INGL}	G to Y LOW			1.3	1.4	1.6	1.9	2.7	ns			
Input Module Predicted Routing Delays²												
t _{IRD1}	FO = 1 Routing Delay			2.0	2.2	2.5	3.0	4.2	ns			
t _{IRD2}	FO = 2 Routing Delay			2.3	2.5	2.9	3.4	4.7	ns			
t _{IRD3}	FO = 3 Routing Delay			2.5	2.8	3.2	3.7	5.2	ns			
t _{IRD4}	FO = 4 Routing Delay			2.8	3.1	3.5	4.1	5.7	ns			
t _{IRD8}	FO = 8 Routing Delay			3.7	4.1	4.7	5.5	7.7	ns			
Global Clock Network												
t _{CKH}	Input LOW to HIGH	FO = 32		2.4	2.7	3.0	3.6	5.0	ns			
		FO = 256		2.7	3.0	3.4	4.0	5.5	ns			
t _{CKL}	Input HIGH to LOW	FO = 32		3.5	3.9	4.4	5.2	7.3	ns			
		FO = 256		3.9	4.3	4.9	5.7	8.0	ns			
t _{PWH}	Minimum Pulse Width HIGH	FO = 32	1.2	1.4	1.5	1.8	2.5	ns				
		FO = 256	1.3	1.5	1.7	2.0	2.7	ns				
t _{PWL}	Minimum Pulse Width LOW	FO = 32	1.2	1.4	1.5	1.8	2.5	ns				
		FO = 256	1.3	1.5	1.7	2.0	2.7	ns				
t _{CKSW}	Maximum Skew	FO = 32		0.3	0.3	0.4	0.5	0.6	ns			
		FO = 256		0.3	0.3	0.4	0.5	0.6	ns			
t _{SUEXT}	Input Latch External Set-Up	FO = 32	0.0	0.0	0.0	0.0	0.0	0.0	ns			
		FO = 256	0.0	0.0	0.0	0.0	0.0	0.0	ns			
t _{HEXT}	Input Latch External Hold	FO = 32	2.3	2.6	3.0	3.5	4.9	ns				
		FO = 256	2.2	2.4	3.3	3.9	5.5	ns				
t _P	Minimum Period	FO = 32	3.4	3.7	4.0	4.7	7.8	ns				
		FO = 256	3.7	4.1	4.5	5.2	8.6	ns				
f _{MAX}	Maximum Frequency	FO = 32		296	269	247	215	129	MHz			
		FO = 256		268	244	224	195	117	MHz			

Table 41 • A42MX16 Timing Characteristics (Nominal 3.3 V Operation) (continued)(Worst-Case Commercial Conditions, VCCA = 3.0 V, TJ = 70°C)

Parameter / Description		-3 Speed		-2 Speed		-1 Speed		Std Speed		-F Speed	
		Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.
Logic Module Sequential Timing^{3, 4}											
t _{SUD}	Flip-Flop (Latch) Data Input Set-Up	0.5	0.5	0.6	0.6	0.7	0.7	0.9	0.9	ns	
t _{HD}	Flip-Flop (Latch) Data Input Hold	0.0	0.0	0.0	0.0	0.0	0.0	0.0	0.0	ns	
t _{SUENA}	Flip-Flop (Latch) Enable Set-Up	1.0	1.1	1.2	1.2	1.4	1.4	2.0	2.0	ns	
t _{HENA}	Flip-Flop (Latch) Enable Hold	0.0	0.0	0.0	0.0	0.0	0.0	0.0	0.0	ns	
t _{WCLKA}	Flip-Flop (Latch) Clock Active Pulse Width	4.8	5.3	6.0	6.0	7.1	7.1	9.9	9.9	ns	
t _{WASYN}	Flip-Flop (Latch) Asynchronous Pulse Width	6.2	6.9	7.9	7.9	9.2	9.2	12.9	12.9	ns	
t _A	Flip-Flop Clock Input Period	9.5	10.6	12.0	12.0	14.1	14.1	19.8	19.8	ns	
t _{IINH}	Input Buffer Latch Hold	0.0	0.0	0.0	0.0	0.0	0.0	0.0	0.0	ns	
t _{INSU}	Input Buffer Latch Set-Up	0.7	0.8	0.9	0.9	1.01	1.01	1.4	1.4	ns	
t _{OUTH}	Output Buffer Latch Hold	0.0	0.0	0.0	0.0	0.0	0.0	0.0	0.0	ns	
t _{OUTSU}	Output Buffer Latch Set-Up	0.7	0.8	0.89	0.89	1.01	1.01	1.4	1.4	ns	
f _{MAX}	Flip-Flop (Latch) Clock Frequency	129	117	108	108	94	94	56	56	MHz	
Input Module Propagation Delays											
t _{IINYH}	Pad-to-Y HIGH	1.5	1.6	1.9	1.9	2.2	2.2	3.1	3.1	ns	
t _{IINYL}	Pad-to-Y LOW	1.1	1.3	1.4	1.4	1.7	1.7	2.4	2.4	ns	
t _{INGH}	G to Y HIGH	2.0	2.2	2.5	2.5	2.9	2.9	4.1	4.1	ns	
t _{INGL}	G to Y LOW	2.0	2.2	2.5	2.5	2.9	2.9	4.1	4.1	ns	
Input Module Predicted Routing Delays²											
t _{IRD1}	FO = 1 Routing Delay	2.6	2.9	3.2	3.2	3.8	3.8	5.3	5.3	ns	
t _{IRD2}	FO = 2 Routing Delay	2.9	3.2	3.7	3.7	4.3	4.3	6.1	6.1	ns	
t _{IRD3}	FO = 3 Routing Delay	3.3	3.6	4.1	4.1	4.9	4.9	6.8	6.8	ns	
t _{IRD4}	FO = 4 Routing Delay	3.6	4.0	4.6	4.6	5.4	5.4	7.6	7.6	ns	
t _{IRD8}	FO = 8 Routing Delay	5.1	5.6	6.4	6.4	7.5	7.5	10.5	10.5	ns	
Global Clock Network											
t _{CKH}	Input LOW to HIGH	FO = 32	4.4	4.8	5.5	6.5	6.5	9.0	9.0	ns	
		FO = 384	4.8	5.3	6.0	7.1	7.1	9.9	9.9	ns	
t _{CKL}	Input HIGH to LOW	FO = 32	5.3	5.9	6.7	7.8	7.8	11.0	11.0	ns	
		FO = 384	6.2	6.9	7.9	9.2	9.2	12.9	12.9	ns	
t _{PWH}	Minimum Pulse Width HIGH	FO = 32	5.7	6.3	7.1	8.4	8.4	11.8	11.8	ns	
		FO = 384	6.6	7.4	8.3	9.8	9.8	13.7	13.7	ns	

Table 44 • A42MX36 Timing Characteristics (Nominal 5.0 V Operation)(Worst-Case Commercial Conditions, VCCA = 4.75 V, T_J = 70°C)

		-3 Speed		-2 Speed		-1 Speed		Std Speed		-F Speed		Units
Parameter / Description		Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	
t _{SUEXT}	Input Latch External Set-Up	FO = 32	0.0	0.0	0.0	0.0	0.0	0.0	0.0	0.0	ns	
		FO = 635	0.0	0.0	0.0	0.0	0.0	0.0	0.0	0.0	ns	
t _{HEXT}	Input Latch External Hold	FO = 32	2.8	3.2	3.6	4.2	4.9	5.9	6.9	ns	ns	
		FO = 635	3.3	3.7	4.2	4.9	5.9	6.9	ns	ns		
t _P	Minimum Period (1/f _{MAX})	FO = 32	5.5	6.1	6.6	7.6	8.3	12.7	ns	ns		
		FO = 635	6.0	6.6	7.2	8.3	12.7	13.8	ns	ns		
f _{MAX}	Maximum Datapath Frequency	FO = 32	180	164	151	131	79	MHz				
		FO = 635	166	151	139	121	73	MHz				
TTL Output Module Timing⁵												
t _{DLH}	Data-to-Pad HIGH		2.6	2.8	3.2	3.8	5.3	ns				
t _{DHL}	Data-to-Pad LOW		3.0	3.3	3.7	4.4	6.2	ns				
t _{ENZH}	Enable Pad Z to HIGH		2.7	3.0	3.3	3.9	5.5	ns				
t _{ENZL}	Enable Pad Z to LOW		3.0	3.3	3.7	4.3	6.1	ns				
t _{ENHZ}	Enable Pad HIGH to Z		5.3	5.8	6.6	7.8	10.9	ns				

Table 48 • PL68

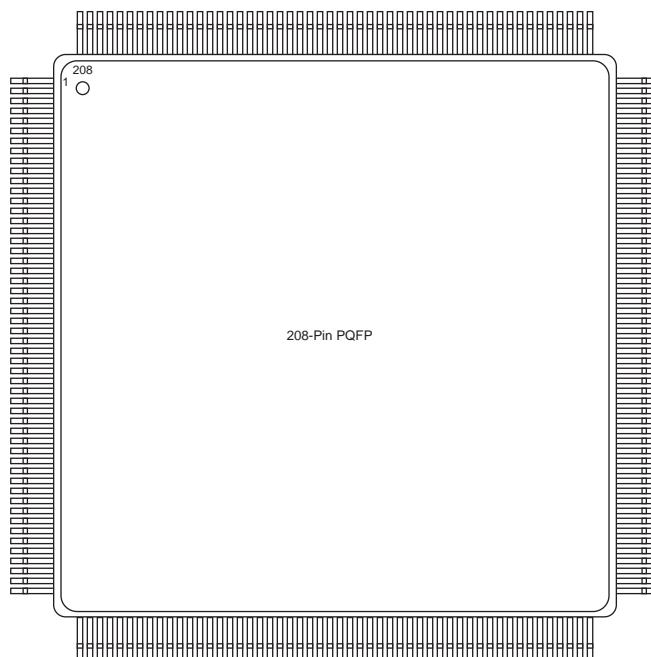
PL68		
Pin Number	A40MX02 Function	A40MX04 Function
24	I/O	I/O
25	VCC	VCC
26	I/O	I/O
27	I/O	I/O
28	I/O	I/O
29	I/O	I/O
30	I/O	I/O
31	I/O	I/O
32	GND	GND
33	I/O	I/O
34	I/O	I/O
35	I/O	I/O
36	I/O	I/O
37	I/O	I/O
38	VCC	VCC
39	I/O	I/O
40	I/O	I/O
41	I/O	I/O
42	I/O	I/O
43	I/O	I/O
44	I/O	I/O
45	I/O	I/O
46	I/O	I/O
47	I/O	I/O
48	I/O	I/O
49	GND	GND
50	I/O	I/O
51	I/O	I/O
52	CLK, I/O	CLK, I/O
53	I/O	I/O
54	MODE	MODE
55	VCC	VCC
56	SDI, I/O	SDI, I/O
57	DCLK, I/O	DCLK, I/O
58	PRA, I/O	PRA, I/O
59	PRB, I/O	PRB, I/O
60	I/O	I/O

Table 51 • PQ144

PQ144	
Pin Number	A42MX09 Function
80	GNDI
81	NC
82	I/O
83	I/O
84	I/O
85	I/O
86	I/O
87	I/O
88	VKS
89	VPP
90	VCC
91	VCCI
92	NC
93	VSV
94	I/O
95	I/O
96	I/O
97	I/O
98	I/O
99	I/O
100	GND
101	GNDI
102	NC
103	I/O
104	I/O
105	I/O
106	I/O
107	I/O
108	I/O
109	I/O
110	SDI
111	I/O
112	I/O
113	I/O
114	I/O
115	I/O
116	GNDQ

Table 52 • PQ160

PQ160			
Pin Number	A42MX09 Function	A42MX16 Function	A42MX24 Function
95	I/O	I/O	I/O
96	I/O	I/O	WD, I/O
97	I/O	I/O	I/O
98	VCCA	VCCA	VCCA
99	GND	GND	GND
100	NC	I/O	I/O
101	I/O	I/O	I/O
102	I/O	I/O	I/O
103	NC	I/O	I/O
104	I/O	I/O	I/O
105	I/O	I/O	I/O
106	I/O	I/O	WD, I/O
107	I/O	I/O	WD, I/O
108	I/O	I/O	I/O
109	GND	GND	GND
110	NC	I/O	I/O
111	I/O	I/O	WD, I/O
112	I/O	I/O	WD, I/O
113	I/O	I/O	I/O
114	NC	VCCI	VCCI
115	I/O	I/O	WD, I/O
116	NC	I/O	WD, I/O
117	I/O	I/O	I/O
118	I/O	I/O	TDI, I/O
119	I/O	I/O	TMS, I/O
120	GND	GND	GND
121	I/O	I/O	I/O
122	I/O	I/O	I/O
123	I/O	I/O	I/O
124	NC	I/O	I/O
125	GND	GND	GND
126	I/O	I/O	I/O
127	I/O	I/O	I/O
128	I/O	I/O	I/O
129	NC	I/O	I/O
130	GND	GND	GND
131	I/O	I/O	I/O

Figure 44 • PQ208**Table 53 • PQ208**

PQ208	A42MX16 Function	A42MX24 Function	A42MX36 Function
1	GND	GND	GND
2	NC	VCCA	VCCA
3	MODE	MODE	MODE
4	I/O	I/O	I/O
5	I/O	I/O	I/O
6	I/O	I/O	I/O
7	I/O	I/O	I/O
8	I/O	I/O	I/O
9	NC	I/O	I/O
10	NC	I/O	I/O
11	NC	I/O	I/O
12	I/O	I/O	I/O
13	I/O	I/O	I/O
14	I/O	I/O	I/O
15	I/O	I/O	I/O
16	NC	I/O	I/O
17	VCCA	VCCA	VCCA
18	I/O	I/O	I/O
19	I/O	I/O	I/O
20	I/O	I/O	I/O

Table 55 • VQ80

VQ80		
Pin Number	A40MX02 Function	A40MX04 Function
13	VCC	VCC
14	I/O	I/O
15	I/O	I/O
16	I/O	I/O
17	NC	I/O
18	NC	I/O
19	NC	I/O
20	VCC	VCC
21	I/O	I/O
22	I/O	I/O
23	I/O	I/O
24	I/O	I/O
25	I/O	I/O
26	I/O	I/O
27	GND	GND
28	I/O	I/O
29	I/O	I/O
30	I/O	I/O
31	I/O	I/O
32	I/O	I/O
33	VCC	VCC
34	I/O	I/O
35	I/O	I/O
36	I/O	I/O
37	I/O	I/O
38	I/O	I/O
39	I/O	I/O
40	I/O	I/O
41	NC	I/O
42	NC	I/O
43	NC	I/O
44	I/O	I/O
45	I/O	I/O
46	I/O	I/O
47	GND	GND
48	I/O	I/O

Table 57 • TQ176

TQ176			
Pin Number	A42MX09 Function	A42MX16 Function	A42MX24 Function
10	NC	I/O	I/O
11	NC	I/O	I/O
12	I/O	I/O	I/O
13	NC	VCCA	VCCA
14	I/O	I/O	I/O
15	I/O	I/O	I/O
16	I/O	I/O	I/O
17	I/O	I/O	I/O
18	GND	GND	GND
19	NC	I/O	I/O
20	NC	I/O	I/O
21	I/O	I/O	I/O
22	NC	I/O	I/O
23	GND	GND	GND
24	NC	VCCI	VCCI
25	VCCA	VCCA	VCCA
26	NC	I/O	I/O
27	NC	I/O	I/O
28	VCCI	VCCA	VCCA
29	NC	I/O	I/O
30	I/O	I/O	I/O
31	I/O	I/O	I/O
32	I/O	I/O	I/O
33	NC	NC	I/O
34	I/O	I/O	I/O
35	I/O	I/O	I/O
36	I/O	I/O	I/O
37	NC	I/O	I/O
38	NC	NC	I/O
39	I/O	I/O	I/O
40	I/O	I/O	I/O
41	I/O	I/O	I/O
42	I/O	I/O	I/O
43	I/O	I/O	I/O
44	I/O	I/O	I/O
45	GND	GND	GND
46	I/O	I/O	TMS, I/O

Table 59 • CQ256

CQ256	
Pin Number	A42MX36 Function
22	I/O
23	I/O
24	I/O
25	I/O
26	VCCA
27	I/O
28	I/O
29	VCCA
30	VCCI
31	GND
32	VCCA
33	LP
34	TCK, I/O
35	I/O
36	GND
37	I/O
38	I/O
39	I/O
40	I/O
41	I/O
42	I/O
43	I/O
44	I/O
45	I/O
46	I/O
47	I/O
48	GND
49	I/O
50	I/O
51	I/O
52	I/O
53	I/O
54	I/O
55	I/O
56	I/O
57	I/O
58	I/O

Table 59 • CQ256

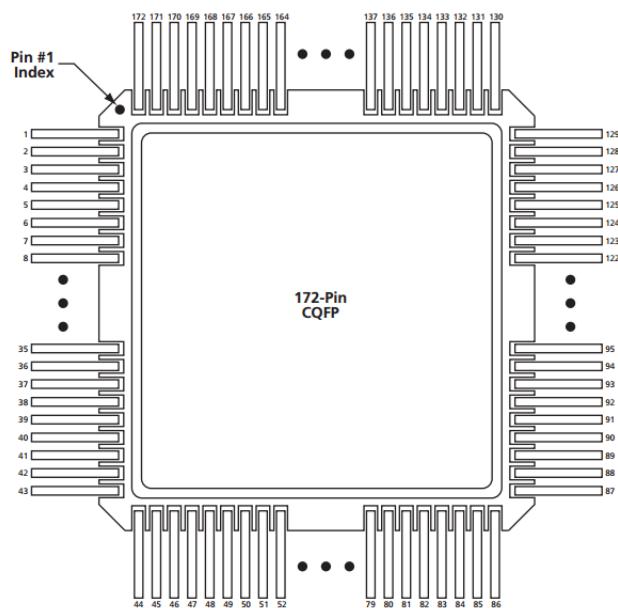
CQ256	
Pin Number	A42MX36 Function
59	I/O
60	VCCA
61	GND
62	GND
63	NC
64	NC
65	NC
66	I/O
67	SDO, TDO, I/O
68	I/O
69	WD, I/O
70	WD, I/O
71	I/O
72	VCCI
73	I/O
74	I/O
75	I/O
76	WD, I/O
77	GND
78	WD, I/O
79	I/O
80	QCLKB, I/O
81	I/O
82	I/O
83	I/O
84	I/O
85	I/O
86	I/O
87	WD, I/O
88	WD, I/O
89	I/O
90	I/O
91	I/O
92	I/O
93	I/O
94	I/O
95	VCCI

Table 60 • BG272

BG272	
Pin Number	A42MX36 Function
M10	GND
M11	GND
M12	GND
M17	I/O
M18	I/O
M19	I/O
M20	I/O
N1	I/O
N2	I/O
N3	I/O
N4	VCCI
N17	VCCI
N18	I/O
N19	I/O
N20	I/O
P1	I/O
P2	I/O
P3	I/O
P4	VCCA
P17	I/O
P18	I/O
P19	I/O
P20	I/O
R1	I/O
R2	I/O
R3	I/O
R4	VCCI
R17	VCCI
R18	I/O
R19	I/O
R20	I/O
T1	I/O
T2	I/O
T3	I/O
T4	I/O
T17	VCCA
T18	I/O

Table 60 • BG272

BG272	
Pin Number	A42MX36 Function
T19	I/O
T20	I/O
U1	I/O
U2	I/O
U3	I/O
U4	I/O
U5	VCCI
U6	WD, I/O
U7	I/O
U8	I/O
U9	WD, I/O
U10	VCCA
U11	VCCI
U12	I/O
U13	I/O
U14	QCLKB, I/O
U15	I/O
U16	VCCI
U17	I/O
U18	GND
U19	I/O
U20	I/O
V1	I/O
V2	I/O
V3	GND
V4	GND
V5	I/O
V6	I/O
V7	I/O
V8	WD, I/O
V9	I/O
V10	I/O
V11	I/O
V12	I/O
V13	WD, I/O
V14	I/O
V15	WD, I/O

Figure 53 • CQ172**Table 62 • CQ172**

CQ172	
Pin Number	A42MX16 Function
1	MODE
2	I/O
3	I/O
4	I/O
5	I/O
6	I/O
7	GND
8	I/O
9	I/O
10	I/O
11	I/O
12	VCC
13	I/O
14	I/O
15	I/O
16	I/O
17	GND
18	I/O
19	I/O
20	I/O